# IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Prior Group Art Unit: 2185

Prior Examiner: Mark A. Connolly

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Applicant(s) Serial No.	:	Bi-Yun YEH et al.  Continuation-in-part of Appl. Serial No. 09/481,714	) ) )
Filed	:	July 29, 2003	) ) INFORMATION
For	:	COMPUTER SYSTEM FOR ACCESSING INITIALIZATION DATA AND METHOD THEREFOR	) DISCLOSURE ) ) )
Attorney Ref.	:	SUND 114 CIP	)

Commissioner for Patents Washington, D.C. 20231

Sir:

In accordance with the duty of disclosure, attached are copies of the Forms PTO-1449 and 892 from the parent application, serial number, **09/481,714**, which the Examiner may wish to consult during examination of this Continuation Application thereof.

Respectfully submitted,

July 29, 2003

Date

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#### Application/Control No. Applicant(s)/Patent Under Reexamination 09/481,714 YEH ET AL. Notice of R ferences Cited Art Unit Examiner Page 1 of 1 2185 Mark Connolly **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 711/5 06-2001 Jeddeloh, Joseph M. Α US-6,253,276 463/44 Takeda et al. US-6,022,274 02-2000 В 12-1994 Fuller et al. 455/417 С US-5,375,161 700/296 D US-4,213,182 07-1980 Eichelberger et al. Ε US-F US-US-G US-Н US-1

# **FOREIGN PATENT DOCUMENTS**

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### **NON-PATENT DOCUMENTS**

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## Application/Control No. Applicant(s)/Patent Under Reexamination 09/481,714 YEH ET AL. Notice of Referenc s Cited Examiner Art Unit Page 1 of 1 Mark Connolly 2185 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,592,675 01-1997 Itoh et al. 365/222 Α US-5,936,526 08-1999 Klein, Dean A. 340/571 В C US-5,937,434 08-1999 Hasbun et al. 711/156 01-2000 D US-6,014,760 Silva et al. 705/8 Ε US-F US-US-G US-Н US-1 J US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.